74ABT8239-bit D-type flip-flop with reset and enable; 3-stateRev. 4 - 7 November 2011Product data sheet

1. General description

The 74ABT823 high-performance BiCMOS device combines low static and dynamic power dissipation with high speed and high output drive.

The 74ABT823 is a 9-bit wide buffered register with clock enable input (\overline{CE}) and master reset input (\overline{MR}) which are ideal for parity bus interfacing in systems using many microprocessors.

The 74ABT823 is designed to eliminate the extra packages required to buffer existing registers and provide extra data width for wider data and address paths of buses carrying parity.

The register is fully edge-triggered. The state of each D input, one set-up time before the LOW-to-HIGH clock transition, is transferred to the corresponding output Q of the flip-flop.

2. Features and benefits

- High-speed parallel registers with positive edge-triggered D-type flip-flops
- Ideal where high speed, light loading, or increased fan-in are required with MOS microprocessors
- Output capability: +64 mA and -32 mA
- Power-on 3-state
- Power-on reset
- Latch-up protection exceeds 500 mA per JESD78B class II level A
- ESD protection:
 - HBM JESD22-A114F exceeds 2000 V
 - MM JESD22-A115-A exceeds 200 V

3. Ordering information

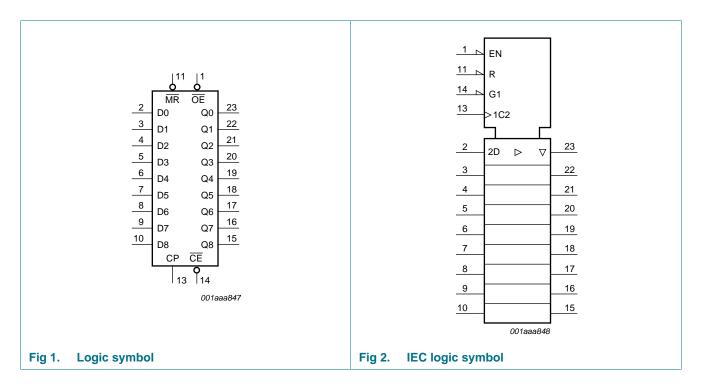
Table 1.Ordering information

Type number	Package			
	Temperature range	Name	Description	Version
74ABT823D	–40 °C to +85 °C	SO24	plastic small outline package; 24 leads; body width 7.5 mm	SOT137-1
74ABT823DB	–40 °C to +85 °C	SSOP24	plastic shrink small outline package; 24 leads; body width 5.3 mm	SOT340-1
74ABT823PW	–40 °C to +85 °C	TSSOP24	plastic thin shrink small outline package; 24 leads; body width 4.4 mm	SOT355-1



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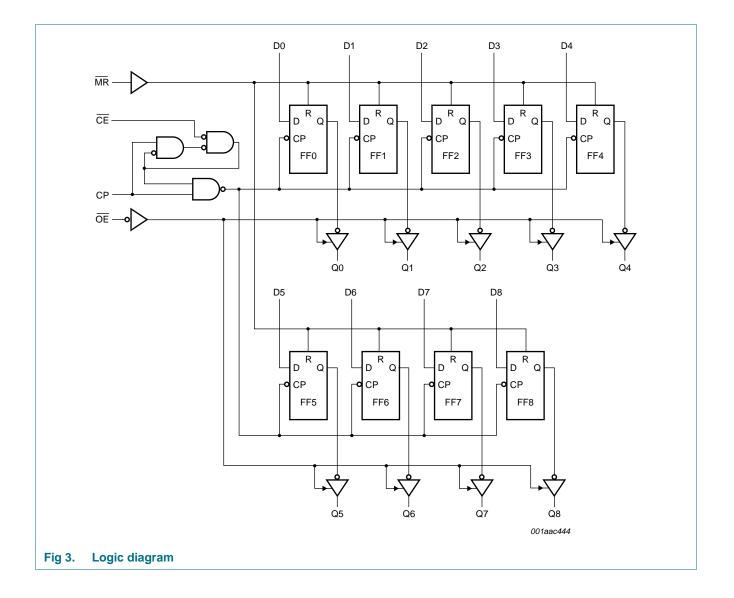
4. Functional diagram



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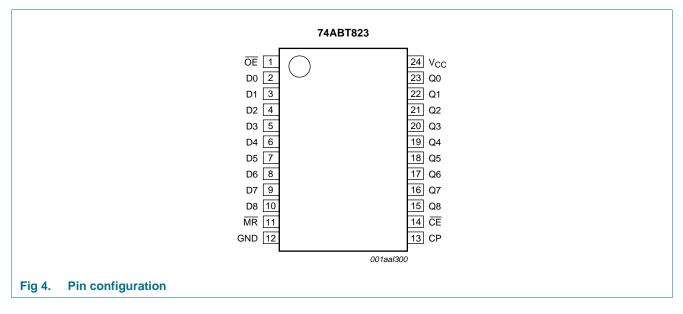


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5. Pinning information

5.1 Pinning



5.2 Pin description

Table 2.Pin description

Symbol	Pin	Description
OE	1	output enable input (active LOW)
D0, D1, D2, D3, D4, D5, D6, D7, D8	2, 3, 4, 5, 6, 7, 8, 9, 10	data input
MR	11	master reset input (active LOW)
GND	12	ground (0 V)
СР	13	clock pulse input (active rising edge)
CE	14	clock enable input (active LOW)
Q8, Q7, Q6, Q5, Q4, Q3, Q3, Q2, Q1, Q0	15, 16, 17, 18, 19, 20, 21, 22, 23	data output
V _{cc}	24	positive supply voltage

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Functional description 6.

6.1 Function table

Input					Output	Operating mode
OE	MR	CE	СР	Dn	Qn	
L	L	Х	Х	Х	L	clear
L	Н	L	1	h	Н	load and read data
L	Н	L	1	Ι	L	
L	Н	Н	NC	Х	NC	hold
Н	Х	Х	Х	Х	Z	high-impedance

[1] H = HIGH voltage level;

L = LOW voltage level;

h = HIGH voltage level one set-up time prior to the LOW-to-HIGH clock transition;

I = LOW voltage level one set-up time prior to the LOW-to-HIGH clock transition;

 \uparrow = LOW-to-HIGH clock transition;

NC = no change;

X = don't care;

Z = high-impedance OFF-state.

Limiting values 7.

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{CC}	supply voltage		-0.5	+7.0	V
VI	input voltage		<u>[1]</u> –1.2	+7.0	V
Vo	output voltage	output in OFF-state or HIGH-state	<u>[1]</u> –0.5	+5.5	V
I _{IK}	input clamping current	V ₁ < 0 V	-18	-	mA
Ι _{ΟΚ}	output clamping current	V _O < 0 V	-50	-	mA
Ι _Ο	output current	output in LOW-state	-	128	mA
Tj	junction temperature		[2] _	150	°C
T _{stg}	storage temperature		-65	+150	°C

[1] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction [2] temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150 °C.

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8. Recommended operating conditions

Table 5.Operating conditions

Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{CC}	supply voltage		4.5	-	5.5	V
VI	input voltage		0	-	V _{CC}	V
VIH	HIGH-level input voltage		2.0	-	-	V
V _{IL}	LOW-level Input voltage		-	-	0.8	V
I _{OH}	HIGH-level output current		-32	-	-	mA
I _{OL}	LOW-level output current		-	-	64	mA
Δt/ΔV	input transition rise and fall rate		0	-	5	ns/V
T _{amb}	ambient temperature	in free air	-40	-	+85	°C

9. Static characteristics

Table 6. **Static characteristics** Symbol Parameter Conditions 25 °C -40 °C to +85 °C Unit Max Min Тур Max Min Vik input clamping voltage $V_{CC} = 4.5 \text{ V}; I_{IK} = -18 \text{ mA}$ -1.2 -0.9 --1.2 V -**HIGH-level** output $V_I = V_{IL} \text{ or } V_{IH}$ VOH voltage V_{CC} = 4.5 V; I_{OH} = -3 mA 2.5 2.9 2.5 V _ _ $V_{CC} = 5.0 \text{ V}; I_{OH} = -3 \text{ mA}$ 3.0 3.4 -3.0 V - $V_{CC} = 4.5 \text{ V}; I_{OH} = -32 \text{ mA}$ 2.4 2.0 V 2.0 --VOL LOW-level output $V_{CC} = 4.5 \text{ V}; I_{OL} = 64 \text{ mA};$ _ 0.42 0.55 -0.55 V voltage $V_{I} = V_{IL} \text{ or } V_{IH}$ $V_{CC} = 5.5 \text{ V}; I_0 = 1 \text{ mA};$ [1] power-up LOW-level 0.13 0.55 0.55 V V_{OL(pu)} -output voltage $V_I = GND \text{ or } V_{CC}$ V_{CC} = 5.5 V; V_{I} = V_{CC} or GND I_I input leakage current ±0.01 ±1.0 ±1.0 μΑ -- $V_{CC} = 0$ V; V_I or V_O ≤ 4.5 V power-off leakage _ ±5.0 ±100 -±100 μΑ **I**OFF current [2] power-up/power-down $V_{CC} = 2.0 \text{ V}; V_{O} = 0.5 \text{ V};$ -±5.0 ±50 ±50 μΑ I_{O(pu/pd)} - $V_1 = GND \text{ or } V_{CC}; \overline{OE} HIGH$ output current $V_{CC} = 5.5 \text{ V}; \text{ V}_{I} = \text{V}_{IL} \text{ or } \text{V}_{IH}$ **OFF-state output** I_{OZ} current $V_{O} = 2.7 V$ 5.0 50 50 μΑ -_ $V_{O} = 0.5 V$ -5.0 -50 --50 μΑ output leakage current HIGH-state; $V_0 = 5.5 V$; I_{LO} 5.0 50 -50 μΑ _ $V_{CC} = 5.5 \text{ V}; \text{ V}_{I} = \text{GND or } V_{CC}$ $V_{CC} = 5.5 \text{ V}; V_{O} = 2.5 \text{ V}$ **3** –180 -50 -50 -180 -50 I_0 output current mΑ Icc supply current $V_{CC} = 5.5 \text{ V}; V_I = \text{GND or } V_{CC}$ outputs HIGH-state 0.5 250 250 uΑ -outputs LOW-state 27 34 _ 34 mΑ outputs disabled 250 -0.5 -250 μΑ

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Table 0.	Static characteristics	commueu							
Symbol	Parameter	Conditions			25 °C		–40 °C te	o +85 °C	Unit
				Min	Тур	Max	Min	Max	
ΔI_{CC}	additional supply current	per input pin; V_{CC} = 5.5 V; one input at 3.4 V; other inputs at V_{CC} or GND	<u>[4]</u>	-	0.5	1.5	-	1.5	mA
CI	input capacitance	$V_{I} = 0 V \text{ or } V_{CC}$		-	4	-	-	-	pF
Co	output capacitance	outputs disabled; $V_O = 0 V \text{ or } V_{CC}$		-	7	-	-	-	pF

Table 6. Static characteristics ...continued

[1] For valid test results, data must not be loaded into the flip-flops (or latches) after applying the power.

[2] This parameter is valid for any V_{CC} between 0 V and 2.1 V, with a transition time of up to 10 ms. From V_{CC} = 2.1 V to V_{CC} = 5 V \pm 10 % a transition time of up to 100 μ s is permitted.

[3] Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

[4] This is the increase in supply current for each input at 3.4 V.

10. Dynamic characteristics

Table 7.Dynamic characteristicsGND = 0 V: for test circuit, see Figure 9.

Symbol	Parameter	Conditions	25 °C	; V _{CC} =	5.0 V	−40 °C to +85 °C; V _{CC} = 5.0 V ± 0.5 V		Unit
			Min	Тур	Max	Min	Max	
f _{max}	maximum frequency	see Figure 5	125	200	-	125	-	MHz
t _{PLH}	LOW to HIGH propagation delay	CP to Qn, see <u>Figure 5</u>	2.1	4.3	5.9	2.1	6.8	ns
t _{PHL}	HIGH to LOW	CP to Qn, see Figure 5	2.2	4.4	6.1	2.2	6.7	ns
	propagation delay	MR to Qn, see Figure 6	2.0	4.1	6.3	2.0	7.1	ns
t _{PZH}	OFF-state to HIGH propagation delay	OE to Qn; see Figure 8	1.0	3.0	4.5	1.0	5.3	ns
t _{PZL}	OFF-state to LOW propagation delay	OE to Qn; see Figure 8	2.2	4.1	5.6	2.2	6.3	ns
t _{PHZ}	HIGH to OFF-state propagation delay	OE to Qn; see Figure 8	2.7	4.8	6.2	2.7	6.9	ns
t _{PLZ}	LOW to OFF-state propagation delay	OE to Qn; see Figure 8	2.5	5.0	6.4	2.5	6.9	ns
t _{su(H)}	set-up time HIGH	Dn to CP; see Figure 7	2.1	0.5	-	2.1	-	ns
		CE to CP; see Figure 7	+2.0	-0.5	-	+2.0	-	ns
t _{su(L)}	set-up time LOW	Dn to CP; see Figure 7	2.1	0.2	-	2.1	-	ns
		CE to CP; see Figure 7	3.3	1.5	-	3.3	-	ns
t _{h(H)}	hold time HIGH	CP to Dn; see Figure 7	1.3	0.0	-	1.3	-	ns
		CP to CE; see Figure 7	+1.0	-1.4	-	+1.0	-	ns
t _{h(L)}	hold time LOW	CP to Dn; see Figure 7	+1.3	-0.3	-	+1.3	-	ns
		CP to \overline{CE} ; see Figure 7	2.0	0.7	-	2.0	-	ns
t _{WH}	pulse width HIGH	CP; see Figure 5	2.9	1.9	-	2.9	-	ns

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GND = 0	V; for test circuit, see	Figure 9.							
Symbol	Parameter	Conditions	25	°C; \	V _{cc} =			o +85 °C; V ± 0.5 V	
			М	in	Тур	Max	Min	Max	
t _{WL}	pulse width LOW	CP; see Figure 5	3.	.8	2.8	-	3.8	-	ns
		MR; see Figure 6	5.	.5	4.0	-	5.5	-	ns
t _{rec}	recovery time	MR to CP; see Figure 6	2.	.5	0.6	-	2.5	-	ns

Table 7. Dynamic characteristics ...continued

11. Waveforms

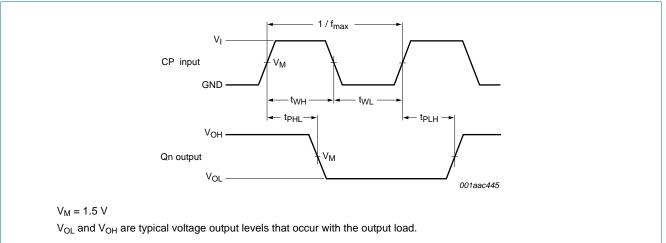
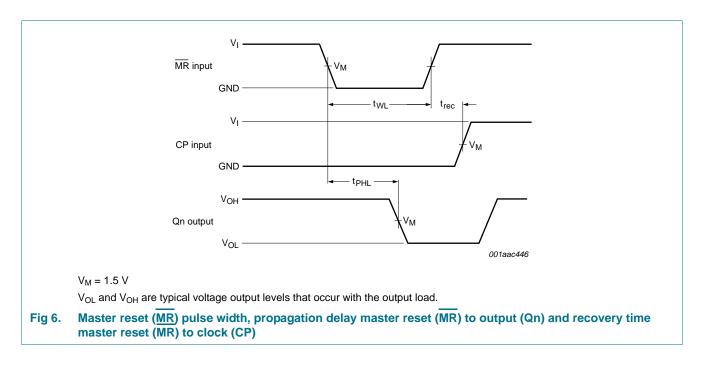
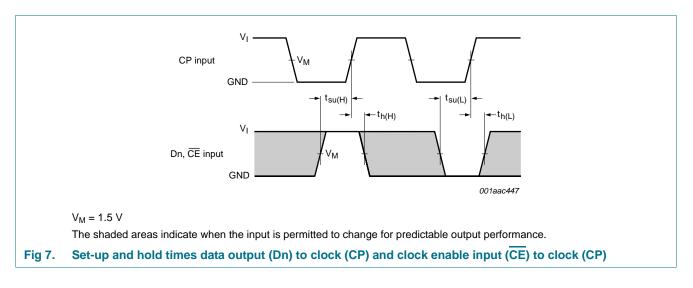


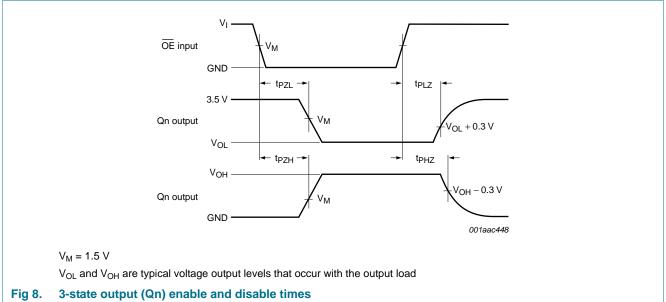
Fig 5. Propagation delay clock input (CP) to output (Qn), clock pulse (CP) width and maximum clock (CP) frequency



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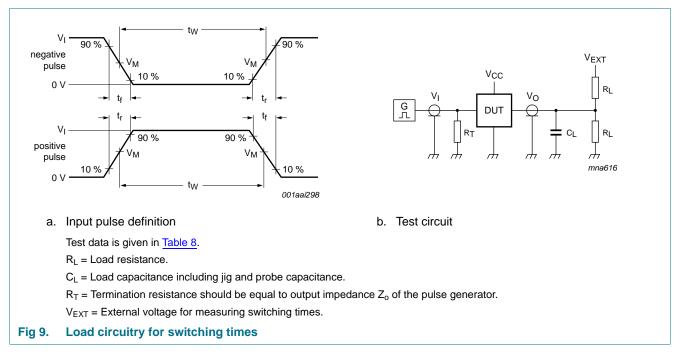


Table 8. Test data

Input			Load		V _{EXT}			
VI	fı	tw	t _r , t _f	CL	RL	t _{PHL} , t _{PLH}	t _{PZH} , t _{PHZ}	t _{PZL} , t _{PLZ}
3.0 V	1 MHz	500 ns	\leq 2.5 ns	50 pF	500 Ω	open	open	7.0 V

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12. Package outline

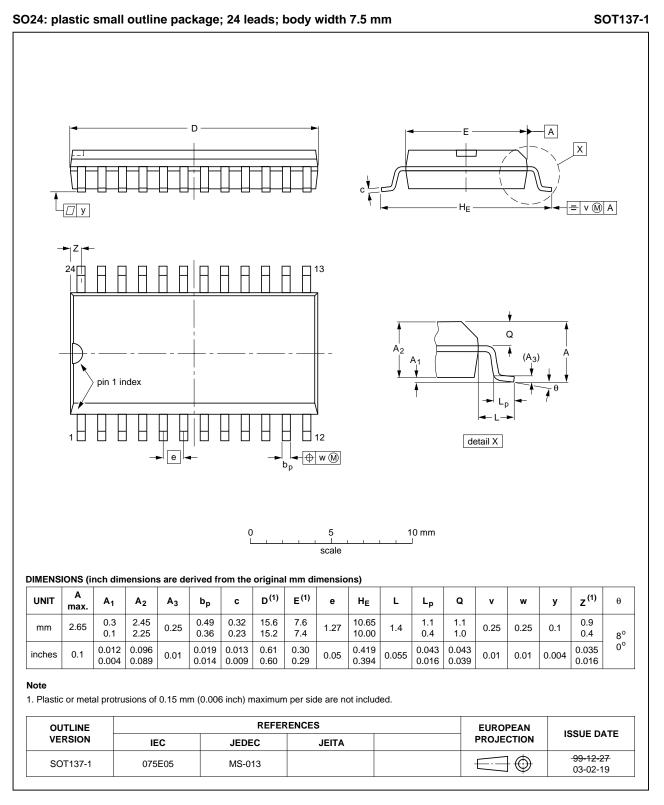


Fig 10. Package outline SOT137-1 (SO24)

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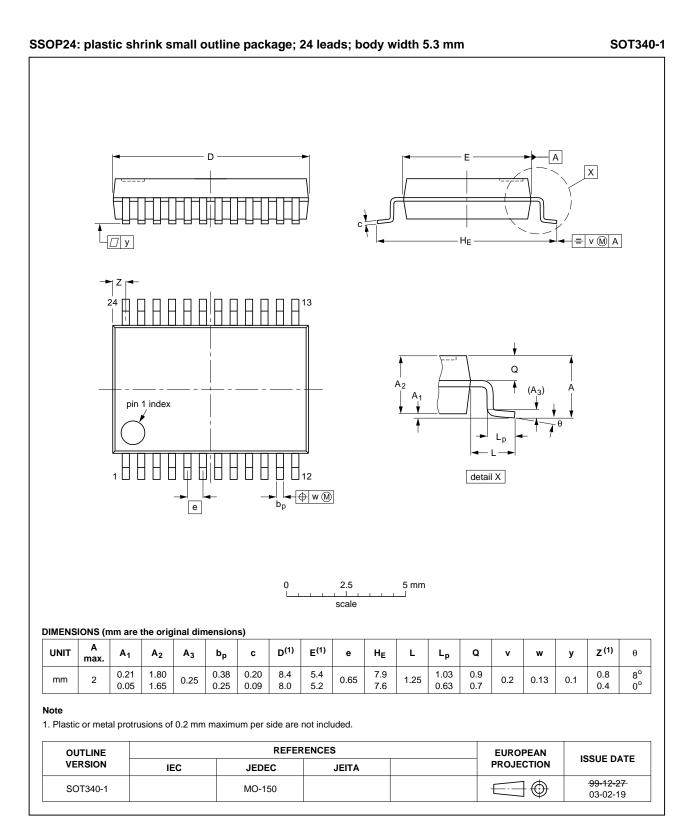
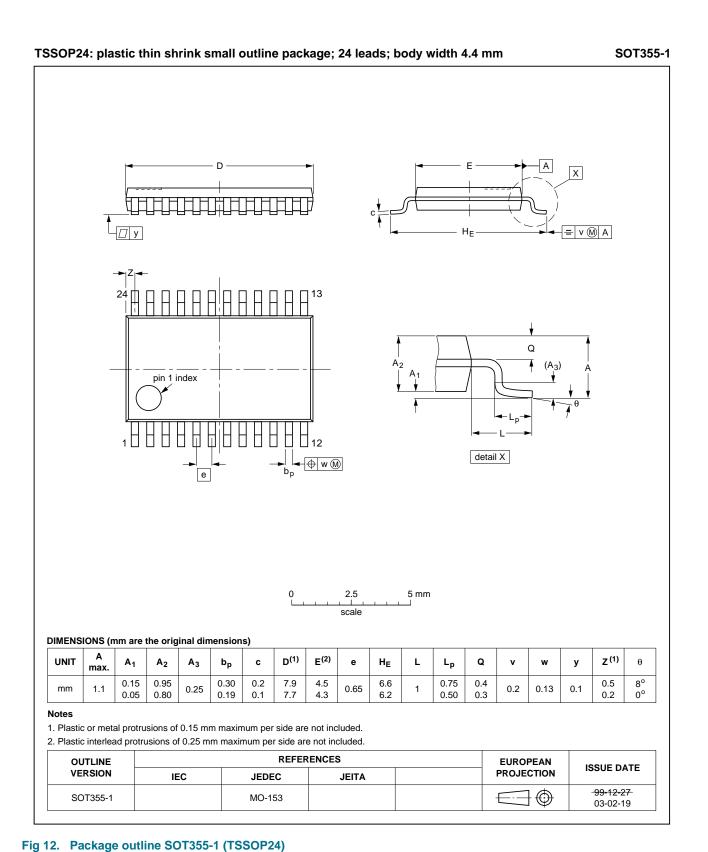


Fig 11. Package outline SOT340-1 (SSOP24)

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13. Abbreviations

Table 9.	Abbreviations
Acronym	Description
BiCMOS	Bipolar Complementary Metal-Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
HBM	Human Body Model
MM	Machine Model
-	

14. Revision history

Table 10.Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74ABT823 v.4	20111107	Product data sheet	-	74ABT823 v.3
Modifications:	 Legal pages 	s updated.		
74ABT823 v.3	20100323	Product data sheet	-	74ABT823 v.2
74ABT823 v.2	20050207	Product specification	-	74ABT823 v.1
74ABT823 v.1	19960314	Product specification	-	

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Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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[2] The term 'short data sheet' is explained in section "Definitions".

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